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Eric W. McFarland

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U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

ADD		Quantitative Electron Spectroscopy of Surfaces: A Standard Data Base for Electron Inelastic Mean Free Paths in Solids by M.P. Seah & W.A. Dench; Surface and Interface Analysis, Vol. 1, No. 1, 1979, pp. 2-11.
ADD		Theoretical Models of Hot Carrier Effects at Metal-Semiconductor Electrodes by Karl W. Frese, Jr., & C. Chen; J. Electrochem. Soc., Vol. 139, No. 11, November, 1992, The Electrochemical Society, Inc., pp. 3234-3243.

EXAMINER Alan D. Smith

DATE CONSIDERED 5/12/03

***EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

